n-Type conduction in a Mg$_3$Sb$_{1.5}$Bi$_{0.5}$ system is achieved with La-doping at cation sites with a peak $zT > 1$. La-doped samples exhibit much higher doping efficiency and dopability compared to other chalcogen-doped samples. This allows greater tunability of the electronic properties. La-doping also significantly improves the thermal stability of n-type Mg$_3$Sb$_{1.5}$Bi$_{0.5}$ measured via a long-term Hall carrier concentration measurement.

The n-type Mg$_3$Sb$_2$–Mg$_3$Bi$_2$ alloy can be an exceptionally efficient thermoelectric material because of its highly degenerate conduction band and extremely low lattice thermal conductivity.\cite{1,2,3,4} The crystal structure of Mg$_3$Sb$_2$ can be thought of in terms of the CaAl$_2$Si$_2$ structure (space group $P\overline{3}m1$), which consists of an octahedrally coordinated Mg$^{2+}$ cation layer and a tetrahedrally coordinated anion structure (Mg$_3$Sb$_2$)$_{2-}$. Long known to be an adequate p-type material through different optimization routes\cite{5,6,7} ($zT \approx 0.7$), band structure calculations on Mg$_3$Sb$_2$ had shown its n-type properties to be superior.\cite{8,9} Attempts to dope the n-type material had failed until recently, when chalcogen (Te, Se, S) doped n-type materials were discovered by different research groups\cite{i,j,k,l} and exhibited a promising $zT$ value of $\sim 1.5$ at 750 K when alloyed with 25\% Mg$_3$Bi$_2$.

Initially, attempts to realize n-type conduction had failed due to charge compensating vacancy type defects at the cation site ($V_{Mg}$). Once an appreciation of the importance of these charge compensating defects and their formation energies were realized,\cite{i,j,k,l} their carrier concentrations were controlled through a process called phase boundary mapping.\cite{9} In the Mg$_3$Sb$_2$ system, there are two distinct thermodynamic states where materials could realistically be synthetized; a Mg-excess state and an Sb-excess state where the Mg$_3$Sb$_2$ matrix is in equilibrium with elemental Mg or Sb, respectively. N-type conduction in Mg$_3$Sb$_2$-compounds is only attainable when the materials are synthesized in the Mg-excess state because the atomic chemical potential in the Mg excess state suppresses the formation of cation vacancies.\cite{10,11,12} In these high thermoelectric performance n-type materials, extrinsic dopants provide the conduction electrons as opposed to Mg interstitial atoms – the suppression of cation vacancies should enable a soluble donor dopant to produce n-type materials.

In addition to controlling the charge compensating defects, previous studies revealed that the limits of achievable carrier concentration varied depending on the type of electron donating defect that was chosen. Mg$_3$Sb$_{1.5}$Bi$_{0.5}$ n-type materials have been synthesized with chalcogen (S, Se, Te) dopants, with S and Se failing to achieve optimal levels of carrier concentration.\cite{13,14} Additionally, chalcogen-doped Mg$_3$Sb$_{1.5}$Bi$_{0.5}$ suffers from high temperature stability issues, which can be observed as a hysteresis or degradation of the n-type carrier concentration with multiple thermal cycles from testing.\cite{15,16,17,18} Finally, chalcogen doped samples have a relatively low doping efficiency, with Te doped samples reaching a carrier concentration of only approximately 40\% of the nominal dopant concentration (expecting 1$e^-$ per Te atom) in an optimally doped sample.

Substituting the Group 2 Mg atoms with Group 3 elements is a plausible way to dope this alloy by donating one electron for each dopant atom to provide the necessary charge carrier concentration and the materials are predicted to be stable.\cite{20} Doping the Mg site might have a more pronounced effect on the intrinsic electrical properties than doping the Sb site since the characteristics of the conduction band largely originate from Mg orbitals.\cite{21,22} In this study, we have investigated the effect of La-doping on the thermoelectric properties. Based on first principles calculations,\cite{23} La was predicted to be a more effective dopant of the cation site for controlling the carrier concentration of n-type Mg$_3$Sb$_{1.5}$Bi$_{0.5}$ compared to the chalcogen dopants.

The loss of Mg in n-type Mg$_3$Sb$_{1.5}$Bi$_{0.5}$ is a significant issue in this system that needs to be managed (with coatings, insulation or cover gas) for practical applications. Experimentally, previous studies observed that it is difficult to sustain degenerate n-type
carrier behavior at high temperature (>450 °C) in chalcogen doped samples.\textsuperscript{1,2,14,15} We suspect the cause of this is due to different vapor pressures and reactivities of the magnesium compared to the pnictide atoms, leading to an overall loss of Mg with extended use. As stated earlier, the thermodynamic state (whether Mg-excess or Sb-excess) of Mg\textsubscript{x}Sb\textsubscript{2} type compounds dramatically affects their defect formation energies and therefore the type and concentration of available charge carriers.

In addition to adjusting the carrier concentration, La substitution at the Mg site might have a substantial effect on the high temperature thermal stability of the Mg\textsubscript{x}Sb\textsubscript{2} alloy. A small amount of La substitution for Yb in Yb\textsubscript{1−x}MnSb\textsubscript{1+x} has been shown to increase the melting point and reduce the material’s overall sublimation rate by changing the bonding character to be more ionic.\textsuperscript{23}

We successfully synthesized n-type Mg\textsubscript{x}Sb\textsubscript{2−x}Bi\textsubscript{0.5} with La-doping and quantitatively evaluated the thermoelectric properties of the material. La-doping is not only effective for realizing n-type conduction but it also shows higher doping efficiency for n-type Mg\textsubscript{x}Sb\textsubscript{2−x}Bi\textsubscript{0.5} compared to chalcogen dopants. Furthermore, improved thermal stability in the La-doped samples was observed with less change in carrier concentration when placed in a dynamic vacuum at elevated temperature.

La-doping in the Mg\textsubscript{3}Sb\textsubscript{2}−Mg,Sb\textsubscript{2} alloy system realizes n-type conduction, with the carrier concentration of this material ranging from \(~2.0 \times 10^{19}\) cm\textsuperscript{−3} to \(~6 \times 10^{19}\) cm\textsuperscript{−3} by changing the nominal La concentration (Fig. 1). Compared to other chalcogen doping, the doping efficiency is higher in the cation-doped material which is consistent with the calculation of the defect formation energy.\textsuperscript{28} This is plainly seen when comparing samples with the same nominal concentration of dopant, with La = 0.01 achieving \(n_H = \sim 5.5 \times 10^{19}\) cm\textsuperscript{−3} and Te = 0.01 achieving \(n_H = \sim 3 \times 10^{19}\) cm\textsuperscript{−3} (Fig S1). The nominal doping efficiency was calculated by taking the ratio of the Hall carrier concentration to the carrier concentration one would assume if all of the dopant atoms were to donate 1 electron as a charge carrier (Table 1). The ideally doped carrier concentration was estimated by taking the nominal number of dopant atoms divided by the volume of the compound. We see that La has a doping efficiency roughly double that of Te at similar concentrations, as shown in Table 1. At high levels of La, the doping efficiency begins to decrease, hinting that a solubility limit may have been reached. This increase offered by cation doping opens the door for better tuning of the electronic properties and potentially reduces impurity phases that would have formed from the excess dopant.

The thermoelectric figure-of-merit, \(zT = 1.0\) at 600 K, is achieved in the La-doped n-type Mg\textsubscript{x}Sb\textsubscript{2−x}Bi\textsubscript{0.5}. The transport properties (Fig. 2) of Mg\textsubscript{x}Sb\textsubscript{2−x}Bi\textsubscript{0.5} (x = 0.005–0.03) exhibit large values of thermopower, indicating typical behavior of degenerate semiconductors. The change in the Seebeck coefficient and electrical conductivity is consistent with the change in the carrier concentration. The thermally-activated conductivity between 300 and 500 K can be attributed to the high resistive grain boundary region.\textsuperscript{23,24} The different scattering mechanisms cannot mathematically explain the drastic crossover of conductivity from the trend of \(T^{−1.5}\) to \(T^{−1.5}\) within 300–600 K. (See the ESI of ref. 23). Improved low temperature conductivity in x = 0.03 suggests that La doping affects both the bulk Fermi level and the grain boundary chemistry.\textsuperscript{23} Among our samples with different La content, the sample with the La content x = 0.005 gives the highest thermoelectric performance with \(zT = 1.0\) at 600 K (Fig. 2).

A material’s figure of merit (\(zT\)) is strongly dependent on its carrier concentration as its electrical conductivity, Seebeck coefficient, and electronic portion of thermal conductivity are all functions of the Fermi level. Therefore, the dimensionless materials quality factor \(B\) was introduced as a fundamental material property not dependent on the Fermi level or carrier concentration.\textsuperscript{25,26} The material’s quality factor \(B\) is defined by the following equation.\textsuperscript{25,26}

\[
B = \left(\frac{k_B}{e}\right)^2 \frac{e(2m_e k_B T)^{1/2}}{3\pi^2 \hbar^3} \frac{\mu_w}{k_L T}
\]

In this regime, we can evaluate the electrical properties and the thermal properties separately as the weighted mobility \(\mu_w\) and the lattice thermal conductivity \(k_L\).

The weighted mobility for each sample is calculated from experimental thermopower and electrical conductivity.\textsuperscript{26,27} The temperature dependency of the calculated weighted mobilities for La-doped (La content x = 0.005, 0.01, 0.03) and Te doped (Te content 0.01) samples is shown in Fig. 3a. From this study, it appears that La doping decreases the intrinsic mobility compared to Te doping. Fig. 3b shows a Pisarenko plot (Seebeck coefficient vs. Hall carrier concentration) at 300 K in which a single parabolic band mass of 1.2m\textsubscript{e} agrees well with both Te doped and La doped samples. This indicates that, at least at
room temperature, the band structure of the conduction band is not significantly changed by doping with La instead of Te.

To evaluate the change in thermal properties with La-doping, the lattice thermal conductivity, $k_L = k_{tot}/\rho_C k_e$, was obtained by calculating $k_e$ using the Wiedeman–Franz law, $k_e = LT/\rho$, where $L$ is the Lorentz number. Assuming acoustic phonon scattering and a single parabolic band model, the Lorentz number was determined using the experimental Seebeck coefficient. It was noted that the electrical contribution to thermal conductivity can be estimated using the bulk Lorenz number as the Fermi level calculated from the Seebeck coefficient mainly reflects the bulk properties. In this method, all the inhomogeneous factors introduced by grain boundary scattering can be approximated to the first order using the conductivity. The calculated lattice thermal conductivities of samples with different La content ($x = 0.005, 0.01, 0.03$) and a sample with a Te content of 0.01 are shown in Fig. 3c. Although we can expect some reduction in lattice thermal conductivity by alloying with heavier elements, we do not observe a significant difference in the lattice thermal conductivities between the La- and Te-doped samples. This is likely because the amount of dopant is too small to meaningfully change the phonon scattering. The $x = 0.03$ sample possesses slightly higher lattice thermal conductivity compared to other samples, which might be attributed to the existence of an impurity phase that has higher thermal conductivity and a relatively large amount of La as reported in a previous report with different amounts of excess Mg. Although this is implied in the decrease in doping efficiency, we could not find a signal for any impurity phase in the XRD results since the nominal amount of La is too small to detect.

The quality factor of this material was calculated to be 0.45 at 600 K, which predicts that $zT = 1.1$ when the material is optimized in terms of carrier concentration. This predicted $zT$ has almost the same value as that of our best sample (La content $x = 0.005$), as seen in the predicted value of $zT$ from the carrier concentration plot (Fig. 3d), which shows that this sample carrier concentration is effectively optimized. The quality factor

**Table 1** Hall carrier concentration at 300 K compared to the ideally doped samples' carrier concentrations

<table>
<thead>
<tr>
<th>$X_x$</th>
<th>Hall carrier concentration ($10^{19}$ cm$^{-3}$)</th>
<th>Ideal doping carrier concentration ($10^{19}$ cm$^{-3}$)</th>
<th>Doping efficiency</th>
</tr>
</thead>
<tbody>
<tr>
<td>$X_x =$ La$_{0.005}$</td>
<td>2.91</td>
<td>3.30</td>
<td>88%</td>
</tr>
<tr>
<td>$X_x =$ La$_{0.01}$</td>
<td>5.67</td>
<td>6.60</td>
<td>86%</td>
</tr>
<tr>
<td>$X_x =$ La$_{0.03}$</td>
<td>6.59</td>
<td>19.8</td>
<td>33%</td>
</tr>
<tr>
<td>$X_x =$ Te$_{0.01}$</td>
<td>3.07</td>
<td>6.60</td>
<td>46%</td>
</tr>
</tbody>
</table>

**Fig. 2** Transport properties of La$_{x}$Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$ ($x = 0.005–0.03$) as a function of temperature: (a) Seebeck coefficient $\alpha$; (b) electrical conductivity $\sigma$; (c) total thermal conductivity $k_{tot}$; (d) figure-of-merit $zT = (\alpha^2\sigma)/kT$. The change in transport properties is consistent with carrier concentration change.
of the La-doped sample is smaller than that of the Te-doped sample, which is due to its smaller weighted mobility. Some of this decrease in mobility is likely attributed to the perturbation of the periodic potential at the conduction band due to the cation site doping by La, but could also be related to impurity phases that vary with processing conditions.

We have conducted Hall measurements under dynamic vacuum for both a Te-doped and La-doped sample for 72 hours under identical conditions. The goal of this was to see the change in Hall carrier concentration as a function of time at the elevated temperature of 450 °C, the results of which are seen in Fig. 4. Both samples exhibit a linear decrease followed by an exponential decrease (in log y scale) in Hall carrier concentration. The Te-doped sample only exhibits a linear decrease in Hall carrier concentration for 1 hour and then exponentially decreases such that within 20 hours, the carrier concentration of the Te sample decreased by more than 65% and reaches below $n_H = 1 \times 10^{18}$ cm$^{-3}$. The La-doped sample shows a slow linear decrease for approximately 25 hours, then begins an exponential type decay. The decrease in this linear region is only about 17% which is much lower than the decrease of 65% in the Te-doped sample. Additionally, over the whole period of measurement the La-doped sample loses 62% of its carriers compared to 80% in the Te doped sample. Finally, we would like to note that this material has an optimized carrier concentration in the range (Fig. 3d). At the end of the measurement the La-doped sample had a carrier concentration of $1.9 \times 10^{19}$ cm$^{-3}$, whereas the Te doped sample had a carrier concentration of $7.2 \times 10^{18}$ cm$^{-3}$.

The exponential change in carrier concentration over time at elevated temperatures in these samples is likely related to the Mg content present in the samples. In a dynamic vacuum, the excess Mg needed to suppress the formation of electron compensating Mg vacancies slowly decreases due to a net loss of Mg. During the regime where there is a slow, linear decrease in Hall carrier concentration, the dopant itself may also be evaporating or its doping efficiency decreasing. However when the Mg evaporation causes the sample to reach the nominal composition where the thermodynamic state is no longer Mg-excess, a dramatic change in carrier concentration will occur.

![Fig. 3](a) Weighted mobility, (b) Pisarenko plot at 300 K, (c) lattice thermal conductivity and (d) $zT$ vs. Hall carrier concentration plots at 600 K for La$_x$Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$ ($x = 0.005–0.03$) and Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$Te$_{0.01}$.

![Fig. 4](a) Weighted mobility, (b) Pisarenko plot at 300 K, (c) lattice thermal conductivity and (d) $zT$ vs. Hall carrier concentration plots at 600 K for La$_x$Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$ ($x = 0.005–0.03$) and Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$Te$_{0.01}$.

![Fig. 4](a) Weighted mobility, (b) Pisarenko plot at 300 K, (c) lattice thermal conductivity and (d) $zT$ vs. Hall carrier concentration plots at 600 K for La$_x$Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$ ($x = 0.005–0.03$) and Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$Te$_{0.01}$.

![Fig. 4](a) Weighted mobility, (b) Pisarenko plot at 300 K, (c) lattice thermal conductivity and (d) $zT$ vs. Hall carrier concentration plots at 600 K for La$_x$Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$ ($x = 0.005–0.03$) and Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$Te$_{0.01}$.

![Fig. 4](a) Weighted mobility, (b) Pisarenko plot at 300 K, (c) lattice thermal conductivity and (d) $zT$ vs. Hall carrier concentration plots at 600 K for La$_x$Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$ ($x = 0.005–0.03$) and Mg$_{3.05}$Sb$_{1.5}$Bi$_{0.5}$Te$_{0.01}$.
Starting at the surface, the material will become p-type, leading to the exponential drop in Hall carrier concentration.

We suspect that cation doping changes the defect energetics in the sample in such a way that it suppresses the net loss of Mg, which results in the improvement of the thermal stability at high temperature as also reported in the 14-1-11 system.\textsuperscript{22} Therefore, we can conclude that La-doping significantly improves the thermal stability of n-type Mg\textsubscript{1-x}Bi\textsubscript{x}, thus, cation-doping can be a more realistic strategy to put this material into practice as thermoelectric generators for applications such as waste heat recovery technology and deep space power generation. Also, we would like to note that the improved thermal stability might also allow the hot pressing of this material at higher temperature. Larger grain size with higher thermal stability might also allow the hot pressing of this procedure with a composition of Mg\textsubscript{1-x}Bi\textsubscript{x}.

Experimental section

La\textsubscript{0.05}Mg\textsubscript{0.95}Bi\textsubscript{1.5} was synthesized with different nominal values of La (x = 0.005–0.3). In addition to these samples, one sample with Te doping was also synthesized using the same procedure with a composition of Mg\textsubscript{1-x}Bi\textsubscript{x}Te\textsubscript{0.01}. We sealed magnesium turnings (99.98%, Alfa Aesar), antimony shots (99.999%, 5N Plus), bismuth granules (99.999%, 5N Plus), lanthanum lumps (99.999%, Alfa Aesar), and Te shots (99.999%, 5N Plus) into stainless steel vials according to the nominal compositions in an argon-filled glove box. The elements were mechanically alloyed using high-energy ball milling with a high-energy ball mill (SPEX 8000D) for two hours. The processed powder was loaded into a graphite die and pressed using an induction heating rapid hot press for 20 minutes at 1073 K and 45 MPa under an argon gas flow.\textsuperscript{22} The Seebeck coefficient of each sample was measured using chromel-Nb thermocouples in a two-probe configuration under a dynamic high vacuum.\textsuperscript{13} The Hall coefficient and electric resistivity were measured simultaneously using a 4-point probe Van der Pauw technique with a 2 T magnetic field under a dynamic high vacuum. Thermal diffusivity \(D\) was measured using a flash method with a Netzsch LFA 457 under a flowing argon atmosphere. The thermal conductivity \(\kappa\) was calculated using \(\kappa = D \times C_p \times d\), where \(d\) is density and \(C_p\) is heat capacity (see the ESI† for \(C_p\) data\textsuperscript{23}). The thermal stability of the materials was measured via the change in the Hall carrier concentration over an extended time at an elevated temperature. With the same set up as the above-mentioned Hall system, we measured the Hall coefficient and resistivity for 72 hours for both La\textsubscript{0.05}Mg\textsubscript{0.95}Bi\textsubscript{1.5} and Mg\textsubscript{1-x}Bi\textsubscript{x}Te\textsubscript{0.01} under a dynamic vacuum at a constant temperature \(\sim 450\) K. Great care was taken to make sure as many experimental details as possible remained identical for both samples, such as measuring them at the same time and polishing them to an identical thickness of 1 mm. We should note that the Hall stage in our set up is made of alumina, which can potentially react with Mg at elevated temperatures.

Conflicts of interest

There are no conflicts to declare.

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